Dual rugged ultrafast rectifier diode, 20 A, 200 VRev. 04 — 2 March 2009Proc

**Product data sheet** 

#### **Product profile** 1.

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#### 1.1 General description

Ultrafast dual epitaxial rectifier diode in a SOT404 (D2PAK) surface-mountable plastic package.

### 1.2 Features and benefits

- High reverse voltage surge capability
- High thermal cycling performance
- Low thermal resistance
- **1.3 Applications** 
  - Output rectifiers in high-frequency switched-mode power supplies

### 1.4 Quick reference data

Table 1.	Quick reference					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>RRM</sub>	repetitive peak reverse voltage		-	-	200	V
I <sub>O(AV)</sub>	average output current	square-wave pulse; $\delta = 0.5$ ; T <sub>mb</sub> ≤ 115 °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	20	A
I <sub>RRM</sub>	repetitive peak reverse current	$t_p = 2 \ \mu s; \ \delta = 0.001$	-	-	0.2	А
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins	-	-	8	kV
Dynamic	characteristics					
t <sub>rr</sub>	reverse recovery time	$I_F = 1 \text{ A}$ ; $V_R = 30 \text{ V}$ ; $dI_F/dt = 100 \text{ A}/\mu\text{s}$ ; $T_j = 25 \text{ °C}$ ; ramp recovery; see Figure 5	-	20	25	ns
		$I_R = 1 \text{ A}; I_F = 0.5 \text{ A}; T_j = 25 \text{ °C}; \text{ measured}$ at reverse current = 0.25 A; step recovery; see Figure 6	-	10	20	ns
Static cha	aracteristics					
VF	forward voltage	I <sub>F</sub> = 8 A; T <sub>i</sub> = 150 °C; see Figure 4	-	0.72	0.85	V



- Soft recovery characteristic minimizes power consuming oscillations
- Surface-mountable package
- Very low on-state loss

### 2. Pinning information

Table 2.	Pinning	information			
Pin	Symbol	Description		Simplified outline	Graphic symbol
1	A1	anode 1			
2	К	cathode	[1]	mb	
3	A2	anode 2			К
mb	К	mounting base; cathode		SOT404 (D2PAK)	sym125

[1] it is not possible to make a connection to pin 2 of the SOT404 package

### 3. Ordering information

#### Table 3.Ordering information

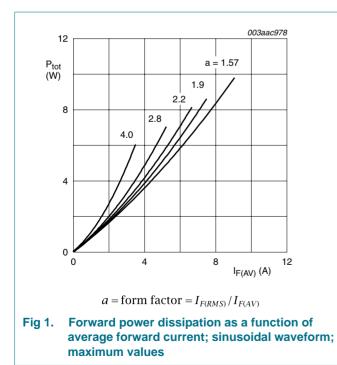
Type number	Package		
	Name	Description	Version
BYV32EB-200	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404

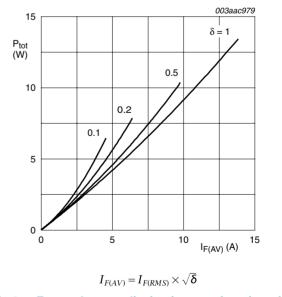
### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>RRM</sub>	repetitive peak reverse voltage		-	200	V
V <sub>RWM</sub>	crest working reverse voltage		-	200	V
V <sub>R</sub>	reverse voltage	DC	-	200	V
I <sub>O(AV)</sub>	average output current	square-wave pulse; $\delta = 0.5$ ; $T_{mb} \le 115$ °C; both diodes conducting; see Figure 1; see Figure 2	-	20	А
I <sub>FRM</sub>	repetitive peak forward current	$\delta$ = 0.5; $t_p$ = 25 $\mu s;$ $T_{mb}$ $\leq$ 115 °C; per diode	-	20	А
I <sub>FSM</sub>	non-repetitive peak forward current	$t_p$ = 8.3 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	137	А
		$t_p$ = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	125	А
I <sub>RRM</sub>	repetitive peak reverse current	$\delta = 0.001; t_p = 2 \ \mu s$	-	0.2	А
I <sub>RSM</sub>	non-repetitive peak reverse current	t <sub>p</sub> = 100 μs	-	0.2	A
T <sub>stg</sub>	storage temperature		-40	150	°C
Tj	junction temperature		-	150	°C
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins	-	8	kV

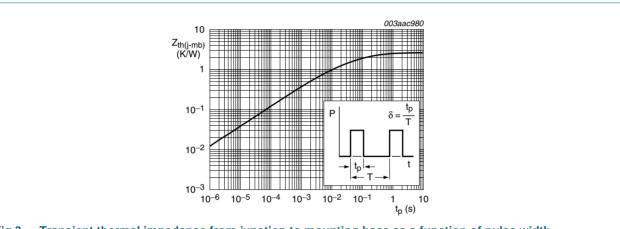






### 5. Thermal characteristics

Table 5.	Thermal characteristics	Thermal characteristics						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	with heatsink compound; both diodes conducting	-	-	1.6	K/W		
		with heatsink compound; per diode; see Figure 3	-	-	2.4	K/W		
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	minimum footprint FR4 board	-	50	-	K/W		

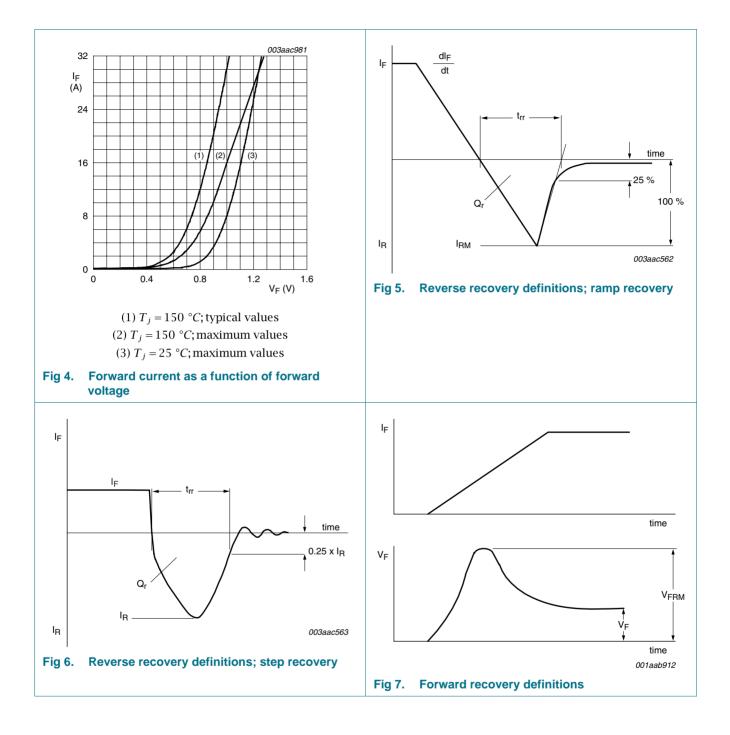


#### Fig 3. Transient thermal impedance from junction to mounting base as a function of pulse width

### 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V <sub>F</sub>	forward voltage	I <sub>F</sub> = 8 A; T <sub>j</sub> = 150 °C; see <u>Figure 4</u>	-	0.72	0.85	V
		I <sub>F</sub> = 20 A; T <sub>j</sub> = 25 °C	-	1	1.15	V
I <sub>R</sub>	reverse current	V <sub>R</sub> = 200 V; T <sub>j</sub> = 25 °C	-	6	30	μA
		V <sub>R</sub> = 200 V; T <sub>j</sub> = 100 °C	-	0.2	0.6	mA
Dynamic	characteristics					
Qr	recovered charge	$I_F = 2 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 20 \text{ A}/\mu\text{s}$	-	8	12.5	nC
t <sub>rr</sub>	reverse recovery time	I <sub>F</sub> = 1 A; V <sub>R</sub> = 30 V; dI <sub>F</sub> /dt = 100 A/μs; ramp recovery; T <sub>j</sub> = 25 °C; see <u>Figure 5</u>	-	20	25	ns
		$I_F = 0.5 \text{ A}$ ; $I_R = 1 \text{ A}$ ; measured at reverse - current = 0.25 A; step recovery; $T_j = 25 \text{ °C}$ ; see Figure 6	-	10	20	ns
V <sub>FR</sub>	forward recovery voltage	$I_F = 1 \text{ A}; \text{ dI}_F/\text{dt} = 10 \text{ A}/\mu\text{s}; \text{ see } \frac{\text{Figure 7}}{1000}$	-	-	1	V

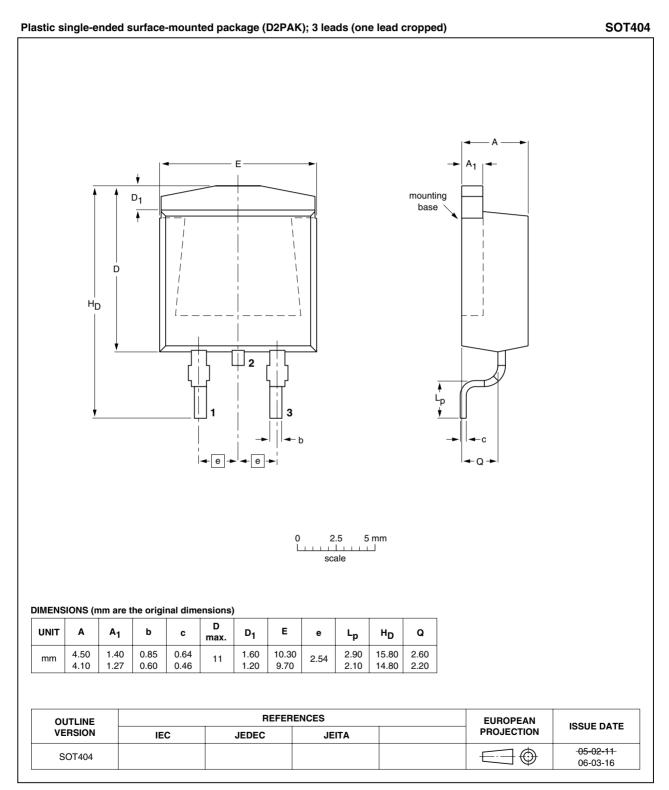
#### Dual rugged ultrafast rectifier diode, 20 A, 200 V



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### 7. Package outline



#### Fig 8. Package outline SOT404 (D2PAK)

### 8. Revision history

Table 7. Revision hist	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BYV32EB-200_4	20090302	Product data sheet	-	BYV32E_SERIES_3
Modifications:		of this data sheet has bee of NXP Semiconductors.	n redesigned to comply w	vith the new identity
	<ul> <li>Legal texts</li> </ul>	have been adapted to the	new company name whe	ere appropriate.
	<ul> <li>Package or</li> </ul>	utline updated.		
	<ul> <li>Type numb</li> </ul>	er BYV32EB-200 separate	ed from data sheet BYV32	2E_SERIES_3
BYV32E_SERIES_3	20010301	Product specification	-	BYV32E_SERIES_2
BYV32E_SERIES_2	19980701	Product specification	-	BYV32EB_SERIES_1
BYV32EB_SERIES_1	19960801	Product specification	-	-

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#### 9.1 Data sheet status

Document status [1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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